Search Notes

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Applicant(s)/Patent Under Reexamination

YOSHINO ET AL.

Examiner

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Art Unit

Stephen M Hepperle

SEARCHED					
Class	Subclass	Date	Examiner		
137	501, 504	3/08	SMH		

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, including citation search	3/08	SMH
PALM inventor search		

INTERFERENCE SEARCH			
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